Notice of References Cited Application/Control No. 09/995,641 Examiner Eric Elcenko Applicant(s)/Patent Under Reexamination WENDELRUP, HEINO Art Unit 2643 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0085263	04-2005	Kim et al.	455/556.1
*	В	US-6,915,119	07-2005	Konishi, Masahiro	455/127.1
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
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	J	US-			
	К	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0085263	04-2005	Kim et al.	455/556.1
*	В	US-2002/0089589	07-2002	Adair et al.	348/158
	С	US-			
	D	US-			
	E	US-			
	F	US-			
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	Н	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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